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August 2012

FGH75T65UPD 650V, 75A Field Stop Trench IGBT

Features

- Maximum Junction Temperature : T_J = 175°C
- Positive Temperaure Co-efficient for easy parallel operating
- · High current capability
- Low saturation voltage: V_{CE(sat)} = 1.65V(Typ.) @ I_C = 75A
- High input impedance
- Tightened Parameter Distribution
- · RoHS compliant
- Short Circuit Ruggedness > 5us @25°C

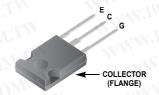


General Description

Using Novel Field Stop Trench IGBT Technology, Fairchild's new series of Field Stop Trench IGBTs offer the optimum performance for Solar Inverter , UPS and Digital Power Generator where low conduction and switching losses are essential.

Applications

· Solar Inverter, UPS, Digital Power Generator





Absolute Maximum Ratings

Symbol	Description		Ratings	Units	
V _{CES}	Collector to Emitter Voltage	MAN TON TOON	650	CAMP	
V_{GES}	Gate to Emitter Voltage	100 r. COM	± 20	VOM.	
Ic	Collector Current	@ T _C = 25°C	150	OUY A	
	Collector Current	@ T _C = 100°C	75	100 A	
I _{CM (1)}	Pulsed Collector Current	MMN. POV.CO	225	A.CO	
I _F	Diode Forward Current	@ T _C = 25°C	75	A	
	Diode Forward Current	@ T _C = 100°C	50	110A	
I _{FM(1)}	Pulsed Diode Maximum Forward C	urrent	225	AOY	
P- 1	Maximum Power Dissipation	@ T _C = 25°C	375	W	
P_{D}	Maximum Power Dissipation	@ T _C = 100°C	187	W	
SCWT	Short Circuit Withstand Time	@ T _C = 25°C	5	us	
T _J	Operating Junction Temperature		-55 to +175	°C	
T _{stg}	Storage Temperature Range		-55 to +175	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

Notes:

Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	WW.	0.40	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case	ANAN TOO	0.86	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	W	40	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Eco Status	Pacing Type	Qty per Tube
FGH75T65UPD	FGH75T65UPD	TO-247	WW OV.C	Ju-	30ea

For Fairchild's definition of "green" Eco Status, please visit: http://www.fairchildsemi.com/company/green/rohs green.html.

Electrical Characteristics of the IGBT T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics (VIIII)					
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V$, $I_C = 1mA$	650	OM.	W -	V
$\frac{\Delta BV_{CES}}{\Delta T_{J}}$	Temperature Coefficient of Breakdown Voltage	V _{GE} = 0V, I _C = 1mA	1100Y.	0.65	TW-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$	1001	.00	250	μΑ
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$	M. Food	$^{V.C_{\Omega_{D_{A}}}}$	±400	nA
On Charac	teristics	Y.COM.TW W	MM:100	ON.CO	MITW	
V _{GE(th)}	G-E Threshold Voltage	I_C = 75mA, V_{CE} = V_{GE}	4.0	6.0	7.5	V
100	OM.	I _C = 75A, V _{GE} = 15V	-W-W-1	1.65	2.3	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 75A, V _{GE} = 15V, T _C = 175°C	WAW	2.05	$CO_{\overline{M}^{\prime}}$	CAA
Dynamic C	Characteristics	100Y.COM.TW	WWV	N.1007	CON.	LTW
C _{ies}	Input Capacitance	$V_{CE} = 30V, V_{GE} = 0V,$	The state of	5665	1	pF
C _{oes}	Output Capacitance		-111	205	W.Co	pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz	1	100	~√ C	pF
Switching	Characteristics	WW.100Y.COM.T		NWW.	100 Y.	O_{M}
t _{d(on)}	Turn-On Delay Time	WW. TOOY.COM	-	32	42	ns
t _r	Rise Time	MMM.Ing CACOMI.	- I	43	56	ns
$t_{d(off)}$	Turn-Off Delay Time	$V_{CC} = 400V, I_{C} = 75A,$	-	166	216	ns
t _f	Fall Time	$R_G = 3\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 25^{\circ}C$	1 -	24	33	ns
E _{on}	Turn-On Switching Loss	mudelive Load, TC = 25 C	<u> </u>	2.85	3.68	
E _{off}	Turn-Off Switching Loss	CON CON		1.20		mJ
				1.20	1.60	mJ mJ
E _{ts}	Total Switching Loss	WW.1007.	M.T.	4.05	1.60 5.3	10 -
E _{ts}	Total Switching Loss Turn-On Delay Time	W. 1007.CO	M.I.M.	-		mJ
		MMM.100X.CO	M.T.W.	4.05	5.3	mJ mJ
t _{d(on)}	Turn-On Delay Time	V _{CC} = 400V, I _C = 75A,) Mr.	4.05	5.3	mJ mJ ns
t _{d(on)}	Turn-On Delay Time Rise Time	$R_G = 3\Omega, V_{GE} = 15V,$	OM.TW	4.05 30 57	5.3	mJ mJ ns ns
$t_{d(on)}$ t_{r} $t_{d(off)}$	Turn-On Delay Time Rise Time Turn-Off Delay Time	V_{CC} = 400V, I_{C} = 75A, R_{G} = 3 Ω , V_{GE} = 15V, Inductive Load, T_{C} = 175 o C	ON TIN	4.05 30 57 176	5.3	mJ mJ ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f t_{on}	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$R_G = 3\Omega, V_{GE} = 15V,$	CONFLA	4.05 30 57 176 21	5.3	mJ mJ ns ns ns
$t_{d(on)}$ t_r $t_{d(off)}$	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss	$R_G = 3\Omega, V_{GE} = 15V,$	CONFLA	4.05 30 57 176 21 4.45	5.3	mJ mJ ns ns ns ns

WWW.100Y.CO

WWW.100Y.9

WWW.1007

WWW.100

WWW.1

NW.100Y.COM.TW

M.TW

Y.COM.

ox.com

Electrical Characteristics of the IGBT (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Units
Qg	Total Gate Charge	W. SI SIWW.IOS	COM.	385	578	nC
Q _{ge}	Gate to Emitter Charge	$V_{CE} = 400V, I_{C} = 75A,$	- COM. 1	45	68	nC
Q _{gc}	Gate to Collector Charge	—— V _{GE} = 15V		210	315	nC

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted

Symbol	Parameter	rameter Test Conditions		Min.	Тур.	Max	Units
V _{FM}	Diode Forward Voltage	I _F = 50A	$T_{\rm C} = 25^{\rm o}{\rm C}$	01-	2.1	2.6	V
V FM	Blode Folward Voltage		$T_{\rm C} = 175^{\rm o}{\rm C}$	on I.C	1.7	N -	
E _{rec}	Reverse Recovery Energy	COM	$T_{\rm C} = 175^{\rm o}{\rm C}$		40	- N	uJ
t _{rr} Dio	Diode Reverse Recovery Time	I _F =50A, dI _F /dt = 200A/μs	$T_{\rm C} = 25^{\rm o}{\rm C}$	100	65	85	ns nC
			$T_{\rm C} = 175^{\rm o}{\rm C}$	N 100 X	127	1.4.	
Q _{rr}	Diode Reverse Recovery Charge		$T_{\rm C} = 25^{\rm o}{\rm C}$	7.00	120	170	
Diode Reverse Recovery C	Blode Neverse Nessovery Sharge		$T_{\rm C} = 175^{\rm o}{\rm C}$	M.	550	-W	

W.100Y.COM.TW

Figure 1. Typical Output Characteristics

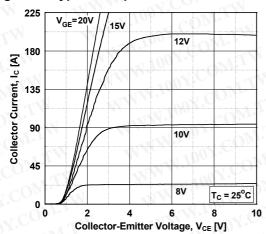


Figure 3. Typical Saturation Voltage Characteristics

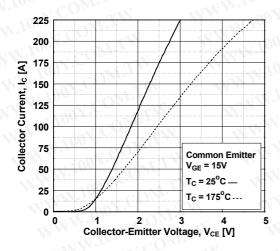


Figure 5. Saturation Voltage vs. Case
Temperature at Variant Current Level

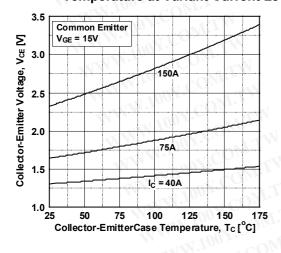


Figure 2. Typical Output Characteristics

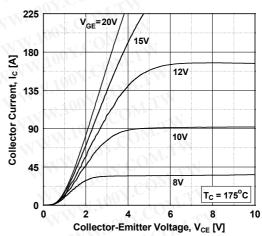


Figure 4. Transfer Characteristics

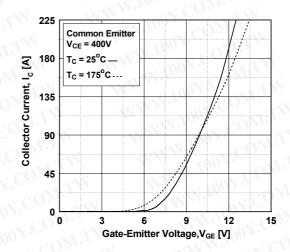


Figure 6. Saturation Voltage vs. V_{GE}

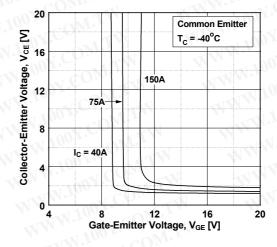


Figure 7. Saturation Voltage vs. V_{GE}

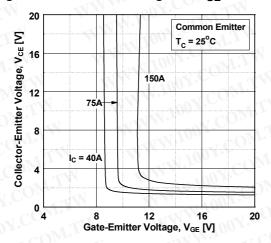


Figure 9. Capacitance Characteristics

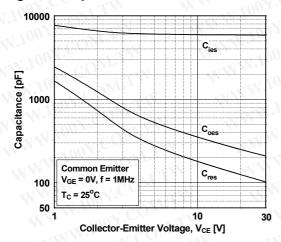


Figure 11. SOA Characteristics

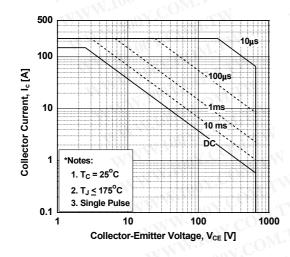


Figure 8. Saturation Voltage vs. V_{GE}

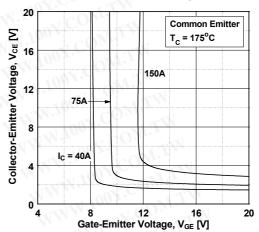


Figure 10. Gate charge Characteristics

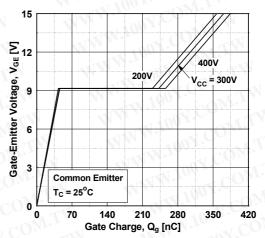


Figure 12. Turn-on Characteristics vs.
Gate Resistance

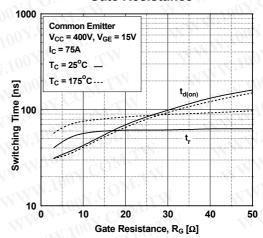


Figure 13. Turn-off Characteristics vs.
Gate Resistance

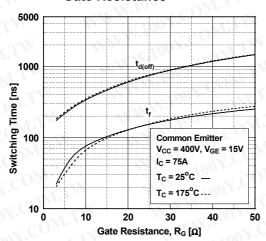


Figure 15. Turn-off Characteristics vs.
Collector Current

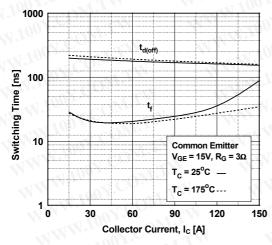


Figure 17. Switching Loss vs. Collector Current

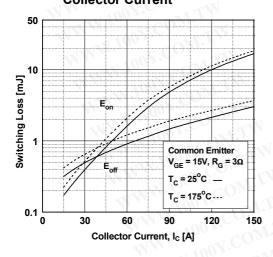


Figure 14. Turn-on Characteristics vs.
Collector Current

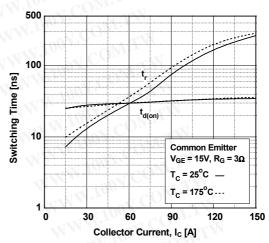


Figure 16. Switching Loss vs.

Gate Resistance

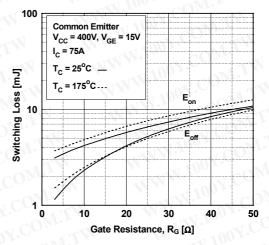


Figure 18. Turn off Switching SOA Characteristics

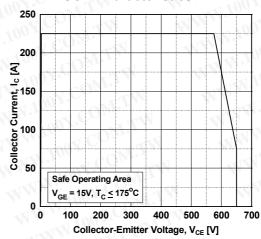


Figure 19. Current Derating

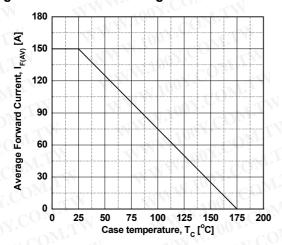


Figure 21. Forward Characteristics

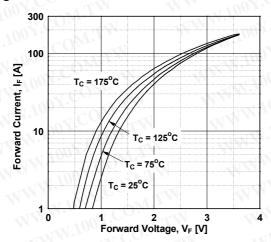


Figure 23. Stored Charge

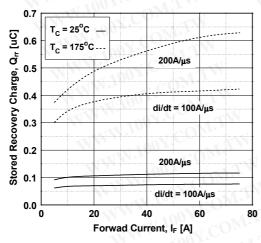


Figure 20. Load Current Vs. Frequence

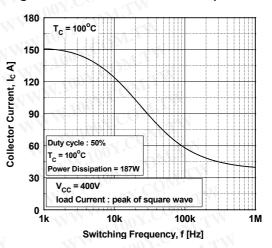


Figure 22. Reverse Recovery Current

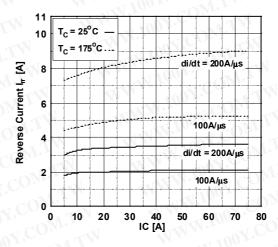


Figure 24. Reverse Recovery Time

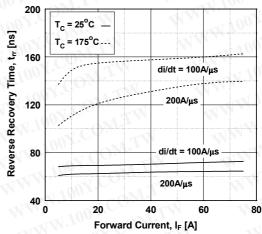


Figure 25. Transient Thermal Impedance of IGBT

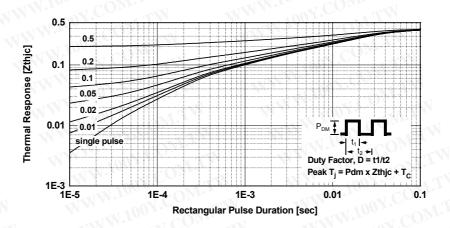
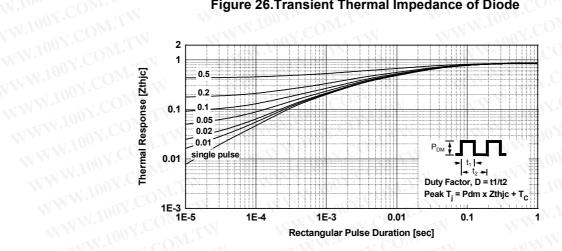
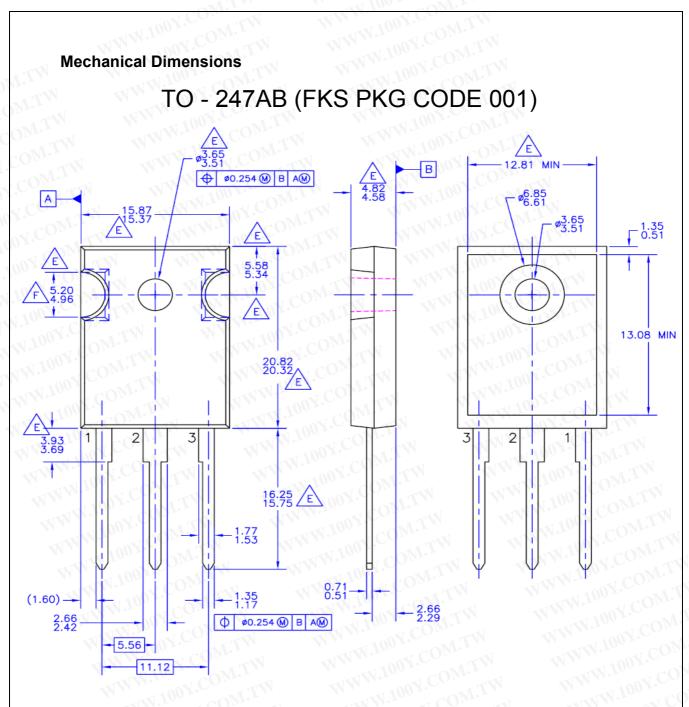


Figure 26.Transient Thermal Impedance of Diode





NOTES: UNLESS OTHERWISE SPECIFIED

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- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5 1994





G. DRAWING FILENAME: MKT-TO247A03 REV02



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